Sheet 1 of 2

LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)					ATTY DOCKET NO.  060942-5013-US  APPLICANT  Geert HEYSE et al.		application no 10/56247	
					FILING DATE December 27, 2005		GROUP	
			U.S. P	ATENT DOCUM	MENTS			
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	A01	5,585,320	12/1996	Tsutsui et al.		03/100	Jobbellios	
	A02	5,587,732	12/1996	Kokubo				
	A03	2003/0072597	04/2003	Someno		<u> </u>		
	A04	2003/0077099	04/2003	Tanaka et al.				
	A05							
	A06							,
<u>-</u>	A07							
	A08							
	A09							

		FOREIG	N PATENT D	OCUMENTS				
	DOCUMENT NUMBER	DATE		COUNTRY	CLASS	SUBCLASS	TRANSL	ATION
							YES	NO
 B01	0 809 212	11/1997	EP					
B02	1 006 000	06/2000	EP					
B03								
B04		***************************************						
B05								

EXAMINER	DATE CONSIDERED			
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	ATTY DOCKET NO. 060942-5013-US	APPLICATION NO 10/562473	
LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	APPLICANT Geert HEYSE et al.		
	FILING DATE December 27, 2005	GROUP	

	OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)				
C01	Patent Abstracts of Japan, Vol. 14, No. 181 (M-0961), April 11, 1990 (JP 02 032892)				
C02	Patent Abstracts of Japan, Vol. 017, No. 483 (M-1472), JP 05 116570				
C03					
C04					
C05					

EXAMINER	DATE CONSIDERED
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.